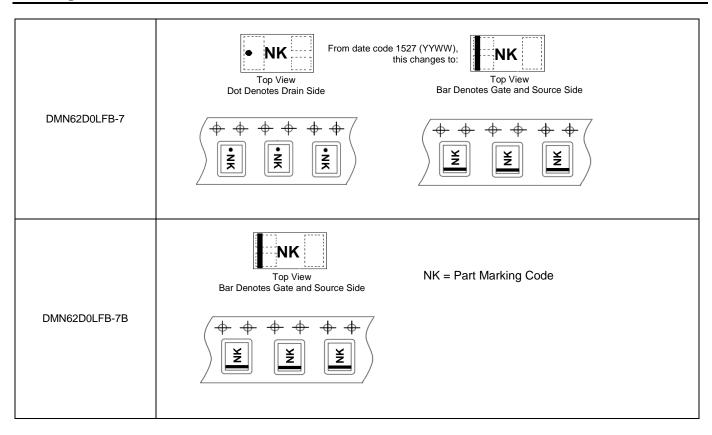


Marking Information



Characteristic			Symbol	Value	Unit
Drain-Source Voltage			VDSS	60	V
Gate-Source Voltage		Vgss	±20	V	
Continuous Drain Current (Note 5) VGS = 4.0V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	320 75	mA
Pulsed Drain Current (Note 6)			IDM	1	А

Thermal Characteristics

Characteristic	Symbol	Max	Unit
Power Dissipation (Note 5)	PD	0.5	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	Reja	258	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

Notes: 5. Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.

6. Repetitive rating, pulse width limited by junction temperature.

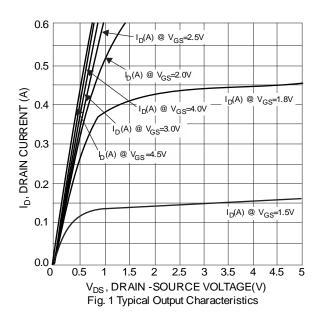


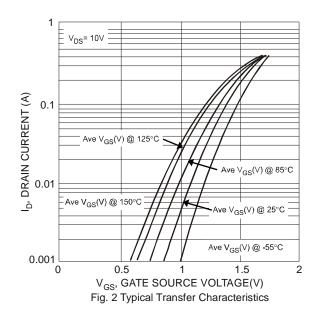
Electrical Characteristics (@ T_A = +25°C, unless otherwise stated.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BVDSS	60	_	_	V	$V_{GS} = 0V, I_{D} = 250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	IDSS	l		1.0	μΑ	$V_{DS} = 60V$, $V_{GS} = 0V$	
	I _{GSS}		_	±100	nA	$V_{GS} = \pm 5V$, $V_{DS} = 0V$	
Gate-Source Leakage		l		±500	nA	$V_{GS} = \pm 10V$, $V_{DS} = 0V$	
			_	±2.0	μA	$V_{GS} = \pm 15V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	Vgs(TH)	0.6	_	1.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
		_	1.3	2	Ω	$V_{GS} = 4V$, $I_D = 100mA$	
Static Drain-Source On-Resistance	Dagger		1.5	2.5		$V_{GS} = 2.5V, I_D = 50mA$	
Static Diani-Source Off-Resistance	RDS(ON)	_	1.9	3		$V_{GS} = 1.8V, I_{D} = 50mA$	
		_	2.6	_		$V_{GS} = 1.5V, I_D = 10mA$	
Forward Transfer Admittance	Y _{fs}	_	0.8	_	S	V _{DS} = 10V, I _D = 200mA	
Diode Forward Voltage	VsD	_	0.9	1.3	V	V _G S = 0V, I _S = 115mA	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		32	64		V 05V V 0V	
Output Capacitance	Coss	_	4.4	9	pF	$V_{DS} = 25V$, $V_{GS} = 0V$, $f = 1.0MHz$	
Reverse Transfer Capacitance	Crss	_	2.9	6			
Gate Resistance	Rg	_	126	250	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg		0.45	0.9			
Gate-Source Charge	Qgs	_	0.08	0.2	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$	
Gate-Drain Charge	Q _{gd}	_	0.08	0.2		$I_D = 250 \text{mA}$	
Turn-On Delay Time	tD(ON)	_	3.4	10	ns	$V_{GS} = 10V, V_{DS} = 30V,$	
Turn-On Rise Time	t _R	_	3.4	10	ns		
Turn-Off Delay Time	t _{D(OFF)}	_	26.4	45	ns	$R_L = 150\Omega, R_g = 25\Omega,$	
Turn-Off Fall Time	tF	_	16.3	30	ns	I _D = 200mA	

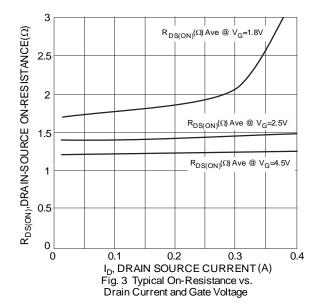
Notes:

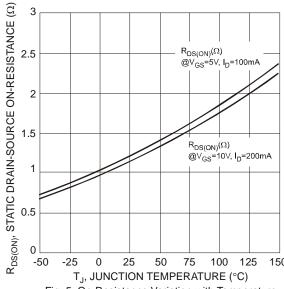
- 7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing.

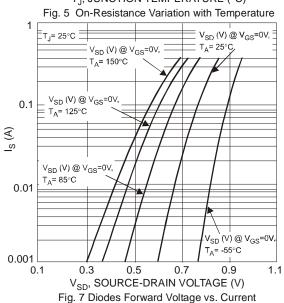


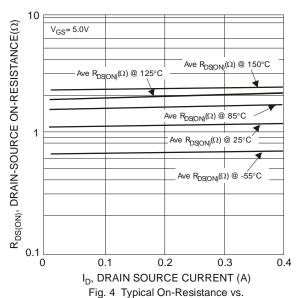


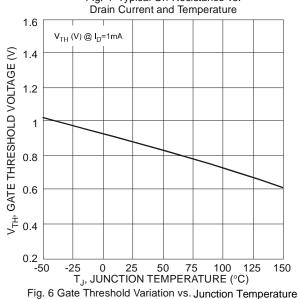






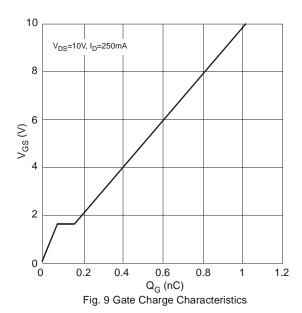


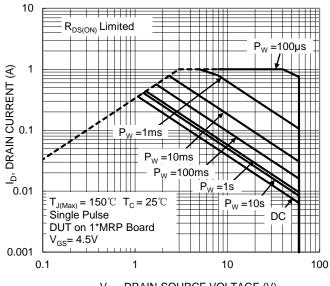




60 f=1MHz 55 JUNCTION CAPACITANCE (pF) 50 45 C_{ISS} Ave(pF) 40 35 30 25 20 15 C_{OSS} Ave(pF) C_{RSS} Ave(pF) 10 5 0 0 15 20 V_{DS}, DRAIN-SOURCE VOLTAGE (V) Fig. 8 Typical Junction Capacitance







V_{DS}, DRAIN-SOURCE VOLTAGE (V) Fig.10 SOA, Safe Operation Area

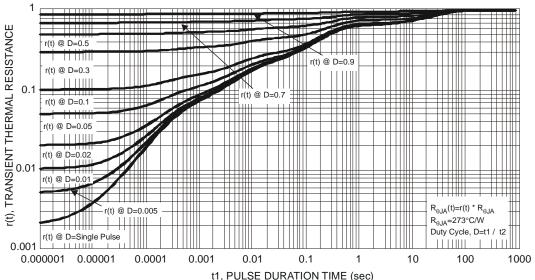


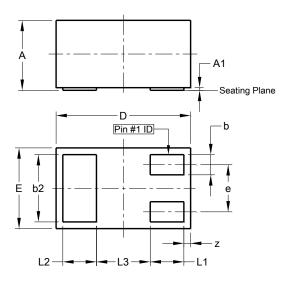
Fig. 11 Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X1-DFN1006-3

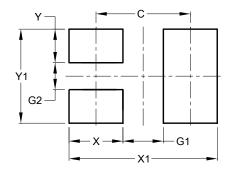


X1-DFN1006-3				
Dim	Min	Max	Тур	
Α	0.47	0.53	0.50	
A1	0.00	0.05	0.03	
b	0.10	0.20	0.15	
b2	0.45	0.55	0.50	
D	0.95	1.075	1.00	
E	0.55	0.675	0.60	
е	1	-	0.35	
L1	0.20	0.30	0.25	
L2	0.20	0.30	0.25	
L3	-	-	0.40	
Z	0.02	0.08	0.05	
All Dimensions in mm				

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X1-DFN1006-3



Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Υ	0.25
V1	0.70



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